Liquid helium Scintillation, application of a large electric field, and generation of HV

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Outline

- LHe scintillation
 - Introduction
 - Measurements with alpha particles
 - Measurements with electrons
- Application of a large electric field in LHe
- Generation of a high electrical potential in LHe

Work presented in this talk have been performed by: Marie Blatnik (Caltech), Vince Cianciolo (ORNL), Steven Clayton (LANL), Scott Curie (LANL), Takeyasu Ito (LANL), Stephen MacDonald (LANL), Chris O'Shaughnessy (LANL), Nguyen Phan (LANL), John Ramsey (LANL/ORNL), George Seidel (Brown), Erick Smith (LANL), Wanchun Wei (LANL), Weijun Yao (ORNL)

Thanks to Nguyen Phan for many slides.

LHe Scintillation



• Recombination leads to formation of excited molecules

$$\operatorname{He}^{+} + e \rightarrow \left(\operatorname{He}_{3}^{+}\right)_{snawball} + \left(e^{-}\right)_{bubble} \rightarrow \operatorname{He}_{2}^{*} + \operatorname{He}$$

Singlet state: decays within ~ 1ns emitting a 80 nm photon (prompt scintillation)

 $\operatorname{He}_2(A^1\Sigma_u^+) \to \operatorname{rad.}\operatorname{decay}$

 Triplet state: has a litefime of ~ 10 s in vacuum. Gives afterpulses through Penning ionization (destructive interaction with each other)

$$\operatorname{He}_{2}\left(a^{3}\Sigma_{u}^{+}\right) + \operatorname{He}_{2}\left(a^{3}\Sigma_{u}^{+}\right) \rightarrow 3\operatorname{He} + \operatorname{He}^{+} + e^{-}$$

or
$$\operatorname{He}_2(a^3\Sigma_u^+) + \operatorname{He}_2(a^3\Sigma_u^+) \to 2\operatorname{He} + \operatorname{He}_2^+ + e^-$$

$$\square \rightarrow \operatorname{He}^{+} + e \rightarrow \left(\operatorname{He}_{3}^{+}\right)_{snawball} + \left(e^{-}\right)_{bubble} \rightarrow \operatorname{He}_{2}^{*} + \operatorname{He}$$



Two types of ionizing particles

Distribution of charges and recombination depends on the type of ionizing particle.



Recombination leads to excited molecules which then decay by emitting 80 nm EUV photons. Electric field suppresses recombination, which in turn results in suppression in scintillation light production. Separated charges can be measured as ionization current.

Studies done by our group

Year	Ionization source	Temperature (K)	Pressure (Torr)	Electric field (kV/cm)	Location	Apparatus
2009*	5.5 MeV α	0.2 — 1.1	SVP	0 — 45	Indiana U	LANL built chamber cooled by IU DR
2019	5.5 MeV α	0.44 — 3.12	600	0 — 40		
2019	364 keV electron	0.44 — 3.12	600	0 — 40	LANL	MSHV** cooled by a ³ He fridge
2019 (To be performed)	n(³ He, ³ H)p	0.44	600	0 — 40		

* Results published in Ito et al., Phys. Rev. A 85, 042718 (2012)

** The MSHV apparatus described in Ito et al. Rev. Sci. Instrum. 87, 045113 (2016)

Apparatus use at IU



Apparatus used at IU

20kV HV feedthrough

Ground electrode



G10 sleeve

HV electrode

UVT acrylic light guide (top surface coated with TPB-PS)



HV line

Results from the measurement at IU

Ito et al., PRA 85, 042718 (2012).



FIG. 15. (Color online) Kramers's theory fit to the electric-field– strength dependence of prompt scintillation yield measured by the current work. The prompt scintillation yield is normalized to the value at E = 0. The curves are calculated using Eq. (9) of Ref. [29]. Predicted 28% reduction in light yield at 75 kV/cm for neutron captures (Ito et al. (2012)). We plan to measure this soon.



FIG. 21. (Color online) Predicted number of prompt EUV photons for LHe scintillation produced by products of ${}^{3}\text{He}(n,p){}^{3}\text{H}$ reaction with x = 0.65 and b = 62 nm.

MSHV based apparatus to study the effect of an E field on LHe scintillation



MSHV system



Model of the setup

Assembly mounted inside the CV **HV Electrode** Electropolished Ground Mesh 6 0 \square Light Guide Sapphire Viewport

COMSOL calculation for the geometry was made. Highest field is around the edge of the HV electrode (~60 kV/cm) & on the mesh wires (~80 kV/cm) vs 40 kV/cm in measurement gap. All measurements were made at ~ 600 torr and no breakdowns were observed.

Component installation into Central Volume



TPB coated light guide installed

Ground mesh and ring installed

All components installed

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View inside the IVC





A model of the electron scintillation yield

Simple model of the scintillation yield vs electric field for electrons:

- *a*: # of electrons and ions that recombine as singlets
- *b*: # of electrons and ions that recombine as triplets
- *x*: ratio of number of singlet excitations to the total number of ionizations

The normalized scintillation yield, y(E), as a function of electric field, E, is given by:

$$y(E) = 1 - \frac{i(E)}{1 + x(1 + b/a)}$$

"Current", which is the fraction of charges that escape recombination as a function of applied electric field.



Data compared with the model





MSHV with polyethylene neutron moderator for measurement with n(³He, ³H)p





Application of a large electric field

Electrical breakdown in LHe

- Data exist for 1.2-4.2 K, mostly at SVP (bulk of the data were taken at 4.2 K)
 - For varying geometries (plane-plane, sphere-plane, sphere-sphere)
 - In general, very little consistency
- No models or theories
- However, a detailed theoretical study of electron multiplication process in LHe indicates a very high intrinsic breakdown field (MV/cm), well above the observed breakdown fields (~100 kV/cm or below) (Belevtsev, NIMA 327, 18 (1993)).
- Generally accepted picture:
 - 1. A vapor bubble is formed on the surface of the electrode e.g. by field emission from roughness on the cathode
 - 2. The vapor bubble grows by some mechanism and forms a column of gas reaching from one electrode to the other
 - 3. Electrical breakdown occurs through the gas
- Parameters that may affect the breakdown include:
 - Electrode material and surface quality
 - Electrode area and/or gap size
 - Temperature and pressure

He temperature vs SVP



HV E-field R&D using Medium Scale HV Test System at LANL





Ito et al., Rev. Sci. Instrum. 87, 045113 (2016).

HV E-field R&D using Medium Scale HV Test System at LANL





Cu ion implanted PMMA electrodes with a mockup cell.

- MSHV main features:
 - 6 liter LHe volume cooled by a 3He fridge
 - Electrode size ~ 12 cm in diameter (~1/5 scale)
 - Electric field: up to 100 kV/cm in 1 cm gap
 - Lowest temperature ~ 0.4 K
 - Pressure: variable between SVP and 1 atm
- Main findings:
 - Stable electric field ≥ 75 kV/cm at 0.4 K for a wide range of pressures with and without PMMA cell inserted between electrodes.
 - Leakage current ≤ 1 pA at 40 kV voltage difference with and without PMMA cell inserted between electrodes.

Ito et al., Rev. Sci. Instrum. 87, 045113 (2016).

High E field R&D with the Small Scale HV apparatus



The electrode gap ~ 0.5 mm. The stressed area ~ 0.3 cm².

Half scale HV test apparatus at LANL



A half-scale electrode system is immersed in 40 liter LHe volume cooled to 0.4 K. HV performance test will be performed with 200 kV direct HV feed. The cryostat is currently being commissioned.



HSHV electrodes



Generation of a high electric potential

Challenge with feeding HV into LHe

- SNS nEDM experiment requires 650 kV in LHe at 0.4 K
- Heat load through the HV conductor
 - Thermal intercept requires electrically-insulating and thermally-conducting material
- Leakage current at the insulator of the HV feedthrough
 - Additional heat load

Cavallo's Multiplier for SNS nEDM



This 1795 technology will be used to generate > 700 kV inside the SNS nEDM Central Volume from 50 kV, eliminating the need for a 700-kV, superfluid-tight, low-leakage-current HV feedthrough and simplifying the design of the experiment.

Clayton et al 2018 JINST 13 P05017

Cavallo HV multiplier development at LANL



Room temperature demonstration



Measured Voltage Prediction based on measured C_{ij}

Clayton et al 2018 JINST 13 P05017

Cavallo HV multiplier development at LANL Cryogenic prototype







Pelletron in LHe?



Pelletron works on a similar principle to Cavallo's multiplier, but allows continuous current delivery. It is better suited for a TPC, which requires a current to be continuously flowing through a resistor chain. (See Clayton et al., JINST 13 P05017)

Thank you for your attention.